U.S. DEP FORM PTO-1449 MENT OF COMMERCE RADEMARK OFFICE serial no : ATTY, DOCKET NO. : (REV. 7-80) 10/536,948 FEZER - PCT LIST OF REFERENCES CITED BY APPLICANT APPLICANT: Eberhard FEZER (Use several sheets if necessary) GROUP: IINTL FILING DATE: NOVEMBER 27,2003 **U.S. PATENT DOCUMENTS** EXAMINER INITIAL DOCUMENT NUMBER DATE NAME CLASS SUBCLASS FILING DATE /MM/ AA 4,359,973 11/1982 Shimada Toshio AB 5,839,351 1/1998 Nakada AC 6,279,456 8/2001 Ueshima et al 4,359,973 AD 11/1982 Shimada 3,583,291 AE 6/1971 Zeedik 3,494,262 **AF** Holcombe FOREIGN PATENT DOCUMENTS DOCUMENT NUMBER DATE COUNTRY CLASS SUBCLASS TRANSLATION YES NO /MM/ DE 2 106 923 ΑI 2/1971 Germany (Spec. Pg.2, +Engl.Abstract) JP 9100745 AJ 4/1997 Japan (+Engl. Abstract) DE 3609019 AK 9/1987 Germany (+English Abstract) AL JP 9 310640 12/1997 Japan (Engl. Abstract) AM EP 0095052 11/1983 Europe (Spec.&Int'l S.R) JP 9 079377 AN 3/1997 Japan + Engl.Abstract AO GB 659 954 10/1951 Great Britian GB 1 593 118 7/1981 Great Britian DE 37 22 435 AQ 2/1998 Germany (+ Engl. Abstract) DE 199 55 197 AR 5/2001 Germany (+Engl.Abstract) DE 101 17 932 AS 10/2002 Germany (+Engl.Abstract) ΑT DE 36 000749 7/1987 Germany (+Engl.Abstract) ΑU ΑV OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, /Marguerite Mcmahon/ (05/10/2007) EXAMINER DATE CONSIDERED EXAMINER: Initial if reference consistered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.